

# Effects of Oxygen Partial Pressure on Oxidation Behavior of CMnSi TRIP Steel in an Oxidation-Reduction Scheme

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An oxidation-reduction scheme is an alternative approach for improving the galvanizability of advanced high-strength steel in the continuous hot-dip galvanizing process. Here, we investigated the effect of oxygen partial pressure ( $P_{O_2}$ ) on the oxidation behavior of a transformation-induced plasticity steel containing 1.5 wt% Si and 1.6 wt% Mn during heating to and holding for 60 s at 700 °C under atmospheres with various  $P_{O_2}$  values. Irrespective of  $P_{O_2}$ , a thin amorphous Si-rich layer of Si-Mn-O was formed underneath the Fe oxide scale (a  $Fe_2O_3/Fe_3O_4$  bilayer) in the heating stage. In contrast to Si, Mn tended to segregate at the scale surface as  $(Fe,Mn)_2O_3$ . The multilayered structure of  $(Fe,Mn)_2O_3/Fe_2O_3/Fe_3O_4$ /amorphous Si-Mn-O remained even after extended oxidizing at 700 °C for 60 s.  $Fe_2O_3$  was the dominantly growing oxide phase in the scale. The enhanced growth rate of  $Fe_2O_3$  with increasing  $P_{O_2}$  resulted in the formation of more Kirkendall voids in the amorphous Si-rich layer and a less Mn segregation at the scale surface. The mechanisms underlying the absence of FeO and the formation of Kirkendall voids are discussed.

**Keywords:** oxidation, transformation-induced plasticity steel, oxidation-reduction scheme, oxygen partial pressure, amorphous Si oxide

## 1. Introduction

The increasing demands for reducing fuel consumption and improving passenger safety have prompted automotive industries to develop advanced high-strength steels (AHSSs) for use in the structural parts of body-in-white (BIW). Among the currently developed AHSSs that contain various amounts of alloying elements, Mn, Si, and/or Al, transformation-induced plasticity (TRIP) steels possess combined properties of high strength and excellent formability, which are desirable for automotive applications [1]. The formable high-strength property of TRIP steels allows thinner-gauged sheets to be used in the BIW while maintaining the strength levels. However, to be used in automotive applications, the TRIP steels need corrosion protection, which is most effectively performed by means of a continuous hot-dip galvanizing process.

In the continuous hot-dip galvanizing process, prior to hot dipping, cold-rolled TRIP steel sheets undergo an intercritical annealing in the ferrite-austenite two-phase temperature range to achieve a multi-phase microstructure

with a fraction of retained austenite after the galvanizing process. Although intercritical annealing is typically performed under a reducing gas mixture of  $N_2$  and 5 – 10%  $H_2$  to protect the steel sheet surface from being oxidized, alloying elements with a high affinity for oxygen, such as Mn, Si and Al, are still enriched and selectively oxidized at the steel sheet surface, leading to poor galvanizability of the steel sheets during the subsequent hot-dip process [2-5].

Therefore, extensive work has been performed to suppress the external oxidation of the alloying elements in AHSSs during intercritical annealing by controlling the dew point (DP) and composition of the annealing gases [6-13]. Increasing the DP in the annealing furnace could promote the alloying elements to shift from undergoing external oxidation to internal oxidation, and thus improve the galvanizability of AHSS sheets. However, external oxidation of the alloying elements could not be completely suppressed because of their high oxygen affinities. Alternatively, the oxidation-reduction scheme is a method of creating a pure Fe layer on the AHSS sheets after the intercritical anneal-

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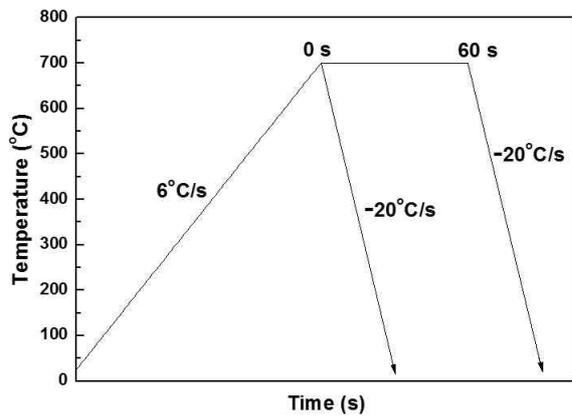
ing step so that the hot-dip galvanizability can be significantly improved [14]. In the oxidation-reduction process, a submicron-thick iron oxide layer is first formed on the steel sheet surface in the pre-heating stage using an oxidizing atmosphere, and then the iron oxide layer is reduced in the subsequent intercritical annealing. However, the pre-oxidation procedure in an oxidizing atmosphere can also cause the alloying elements to be enriched and oxidized at the iron oxide/steel interface. In contrast to the iron oxide, the oxides of the alloying elements cannot be reduced during intercritical annealing, and thus remain even after hot-dip galvanizing. The presence of an oxide

layer (especially  $\text{SiO}_x$ ) underneath the Zn coating overlay could result in easy detachment of the coating layer from the steel substrate during the stamping process. Therefore, for the oxidation-reduction scheme to be successfully used for AHSS sheets, it is important to control the internal oxidation behavior of the alloying elements in the pre-oxidation stage.

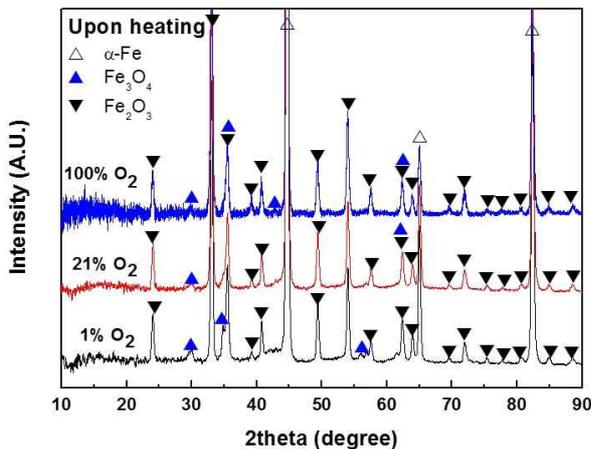
Although many studies have been reported on the oxidations of Fe [15], Fe-Si [16-18], and Fe-Mn [15,19] binary alloys, the short-term oxidation behaviors of AHSSs containing Mn and Si are still poorly understood. This study is aimed at examining the effect of the oxygen partial pressure ( $P_{O_2}$ ) in the ambient gas on the oxidation behavior of a TRIP steel containing 1.6 wt% Mn and 1.5 wt% Si. For this purpose, oxidation of the TRIP steel was performed at 700 °C for 60 s under three different ambient gases:  $\text{N}_2 + 1\% \text{O}_2$ ,  $\text{N}_2 + 21\% \text{O}_2$  and 100%  $\text{O}_2$ .

**Table 1 Chemical composition of the TRIP steel**

| Element | Fe   | Mn  | Si  | C    |
|---------|------|-----|-----|------|
| wt%     | Bal. | 1.6 | 1.5 | 0.08 |



**Fig. 1 Schematic representation of the temperature profile used for the oxidation in the present study. Samples were cooled down either upon ramping up to 700 °C or after isothermal holding at 700 °C for 60 s.**



**Fig. 2 GIXRD patterns for the samples cooled down immediately after heating to 700 °C under three different  $P_{O_2}$  conditions.**

## 2. Experimental procedure

The 590-MPa-grade TRIP steel used in this study was provided in the form of cold-rolled full-hard sheets with dimensions of 120 mm × 200 mm × 1.5 mm by POSCO. The detailed composition of the TRIP steel is listed in Table 1. The steel sheets were cut into samples with dimensions of 50 mm × 50 mm, degreased with kerosene, and then ultrasonically cleaned in acetone. Oxidation of the samples was performed in a rapid thermal annealing (RTA) furnace under the steady flow (0.5 L/min) of 1 atm gas mixtures comprising  $\text{N}_2$  and  $\text{O}_2$  at various volume fractions of  $\text{O}_2$ : 1%, 21%, and 100%. Prior to heating, the RTA chamber was initially vacuum evacuated and purged thrice with the oxidation gas. Then, as shown schematically in Fig. 1, the samples were heated to 700 °C at a rate of 6 °C/s. Either upon reaching 700 °C or after holding at 700 °C for 60 s, the samples were cooled down to room temperature by flowing  $\text{N}_2$  into the chamber to examine the oxidation behaviors during heating to 700 °C and isothermally holding at 700 °C.

The samples oxidized under the three different  $P_{O_2}$  (0.01, 0.21, and 1 atm) were analyzed using grazing incidence X-ray diffraction (GIXRD), glow discharge optical emission spectroscopy (GDOES), and transmission electron microscopy (TEM) along with an energy-dispersive X-ray spectroscopy (EDX). The cross-sectional TEM samples were prepared by a focused ion beam (FIB) milling after deposition of a Pt layer on the sample surface. The GIXRD analyses were performed using  $\text{Cu-K}\alpha$  radiation with a grazing incidence angle of 2°.

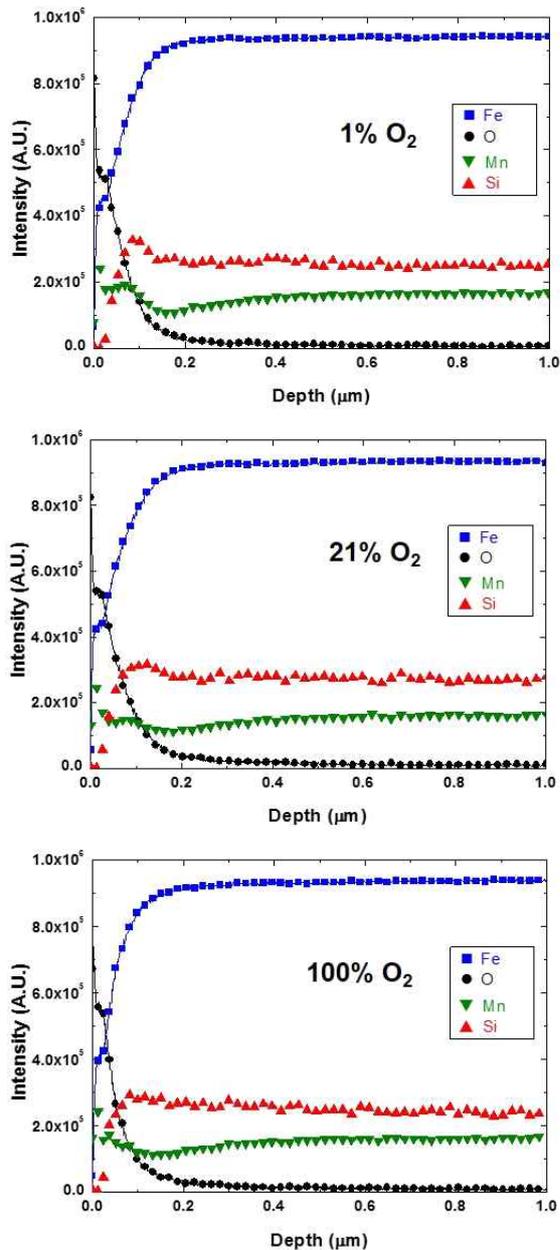


Fig. 3 GDOES depth profiles for elemental distributions in the scales formed in the heating stage under different ambient conditions: (a)  $N_2 + 1\% O_2$ , (b)  $N_2 + 21\% O_2$ , and (c)  $100\% O_2$ .

### 3. Experimental results

#### 3.1. Oxidation behavior in the heating stage

To examine the effect of the ambient oxygen content on the oxidation behavior in the heating stage, the TRIP steel samples were cooled down immediately after heating up to  $700\text{ }^\circ\text{C}$  at a rate of  $6\text{ }^\circ\text{C/s}$  under different  $P_{O_2}$ . As shown in Fig. 2, the samples heated under the different atmospheres exhibited similar GIXRD patterns where only

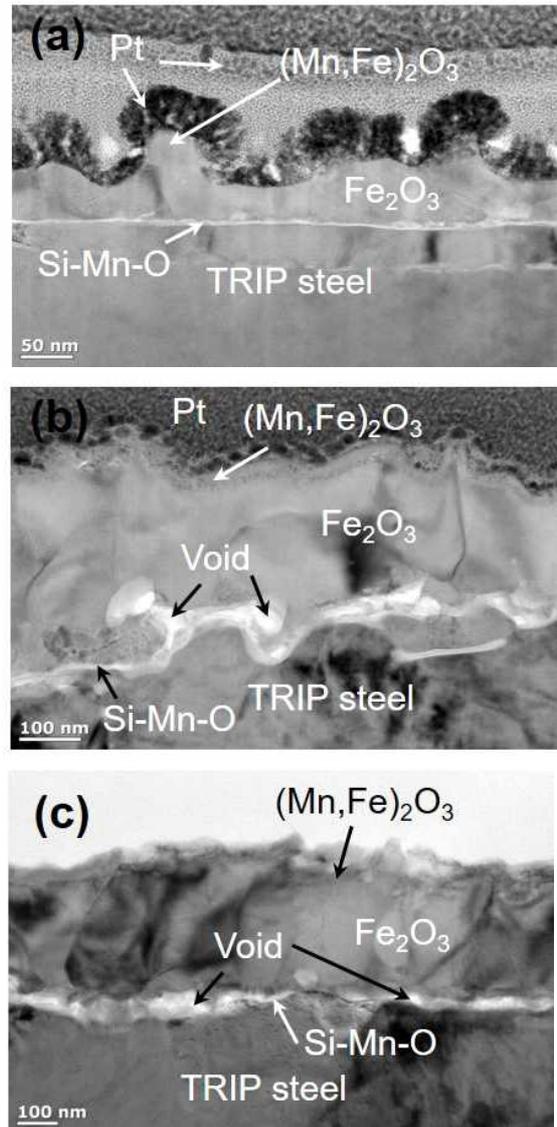


Fig. 4 Cross-sectional TEM micrographs showing the scales formed in the heating stage under different ambient conditions: (a)  $N_2 + 1\% O_2$ , (b)  $N_2 + 21\% O_2$ , and (c)  $100\% O_2$ . Note that the micrographs were taken at different magnifications.

oxide peaks of  $Fe_2O_3$  and  $Fe_3O_4$  were detected along with those of  $\alpha\text{-Fe}$ . Strong intensities of the  $Fe_2O_3$  peaks indicated that  $Fe_2O_3$  was the major oxide phase in the scales formed under all atmospheres. No other oxides of the alloying elements Si and Mn were detected.

Fig. 3 compares the GDOES depth profiles of elemental distributions in the scales formed under the different atmospheres. By measuring the depth at which the Fe and O profiles cross each other, the scale thickness was estimated to be approximately  $30\text{ nm}$  in all the samples. Mn exhibited a tendency to segregate at the top of the scale whereas Si segregated internally, underneath the scale. A

noticeable difference depending on the oxidizing atmospheres was the intensity and width of the Si peak underneath the scale; it became lower in intensity and broader in width with increasing  $P_{O_2}$ .

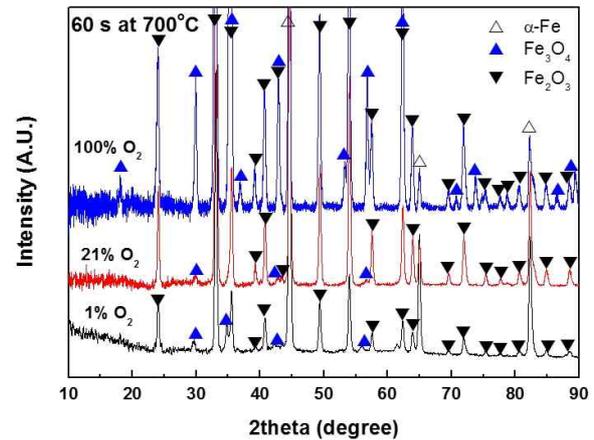
Fig. 4 shows the cross-sectional TEM micrographs of the scales depending on the oxidizing atmosphere. It is noted that the micrographs shown in Fig. 4 were taken at different magnifications. As expected from the GDOES results, all the samples exhibited a Si-rich layer with a bright contrast at the scale/steel interface. High-resolution images (not shown here) of the Si-rich layer revealed that the layer was amorphous. Considering the GDOES depth profiles of Mn shown in Fig. 3 that exhibited secondary intensity peaks at the same locations as those of the Si peaks, the Si-rich layer underneath the Fe-oxide scale should be an amorphous oxide layer of Si-Mn-O. It is interesting to note from Fig. 4 that micro-voids were present in the amorphous Si-Mn-O layer, their number increasing with increasing  $P_{O_2}$ . This increased void formation in the Si-Mn-O layer with increasing  $P_{O_2}$  is likely to be the reason for the GDOES depth profiles showing a lower and broad Si peak with increasing  $P_{O_2}$ . The mechanism behind the void formation will be further discussed in the following section.

In contrast to the scale thickness estimated from the GDOES depth profiles, the cross-sectional TEM micrographs shown in Fig. 4 revealed that the scale thickness was increased with increasing  $P_{O_2}$ . The scale thicknesses were determined from the cross-sectional TEM micrographs by dividing the area of the Fe-oxide scale by the linear interface length. As summarized in Table 2, the scale thickness increased from 58 nm to 374 nm by increasing  $P_{O_2}$  from 0.01 atm to 1 atm. The underestimation of the scale thicknesses from the GDOES profiles was likely attributed to an improper calibration of the depth profiling rate and the use of a large sputtering area (5 mm in diameter) covering local variations in the scale topology.

### 3.2. Oxidation behavior during isothermal oxidation at 700 °C

**Table 2 Scale thicknesses measured from cross-sectional TEM micrographs**

| O <sub>2</sub> content (vol.%) | Scale thickness (nm) |                      |
|--------------------------------|----------------------|----------------------|
|                                | Upon heating         | After 60 s at 700 °C |
| 1                              | 58                   | 144                  |
| 21                             | 147                  | 510                  |
| 100                            | 374                  | 1144                 |



**Fig. 5 GIXRD patterns for the samples after extended oxidation at 700 °C for 60 s under three different  $P_{O_2}$  conditions.**

The TRIP steel samples heated to 700 °C at a rate of 6 °C/s were further oxidized isothermally at 700 °C for 60 s before being rapidly cooled down to room temperature. Fig. 5 shows the GIXRD patterns of the samples oxidized under the atmospheres with different  $P_{O_2}$ . The oxide peaks detected were  $Fe_2O_3$  and  $Fe_3O_4$  regardless of  $P_{O_2}$ . Compared to the corresponding GIXRD patterns in Fig. 2, the changes in the peak intensities of  $Fe_2O_3$  and  $Fe_3O_4$  after oxidizing further at 700 °C for 60 s were significantly dependent on the ambient  $P_{O_2}$ : no significant changes were observed for the 1%  $O_2$  atmosphere, there was a significant increase of the  $Fe_2O_3$  peaks in the case of the 21%  $O_2$  atmosphere, and a significant increase in both the  $Fe_2O_3$  and  $Fe_3O_4$  peaks in the case of the 100%  $O_2$  atmosphere. Surprisingly, there were no FeO peaks detected in this study. It is known that FeO is the predominant oxide phase formed when pure Fe is oxidized at temperatures above 570 °C [15]. The absence of FeO in this study was likely because of the presence of an amorphous Si-Mn-O layer at the scale/steel interface and will be further discussed later.

Fig. 6 shows the GDOES depth profiles obtained after the extended oxidation at 700 °C for 60 s. Noticeable differences from the profiles shown in Fig. 3 were the scale thickness and the distributions of Si and Mn. In contrast to the case of the 1%  $O_2$  atmosphere (Fig. 6a), the 21% and 100%  $O_2$  atmospheres (Fig. 6b and c, respectively) showed a significant growth of the Fe oxide scale after the extended oxidation, as determined from the depth at which the Fe and O profiles cross each other, which was in accordance with the GIXRD results. Regardless of the  $O_2$  content in the oxidizing atmosphere, the alloying element Mn had a strong tendency to segregate at the scale surface during the extended oxidation at 700 °C, whereas

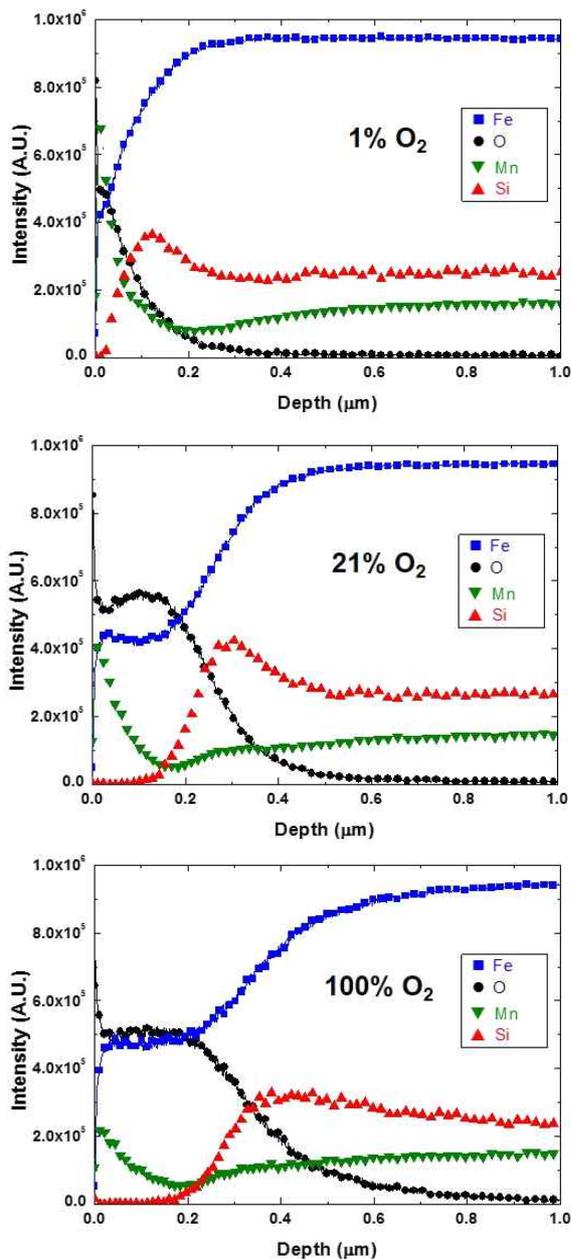


Fig. 6 GDOES depth profiles for elemental distributions in the scales formed after extended oxidation at 700 °C for 60 s under different ambient conditions: (a)  $N_2 + 1\% O_2$ , (b)  $N_2 + 21\% O_2$ , and (c)  $100\% O_2$ .

the alloying element Si was oxidized internally, underneath the Fe oxide scale. A comparison of the Mn intensities at the scale surface suggested that the surface segregation of Mn should become more significant by lowering  $P_{O_2}$  in the ambience, which was partly because of the reduced growth rate of the Fe oxide scale.

The microstructure of the scales formed after the extended oxidation was examined using cross-sectional

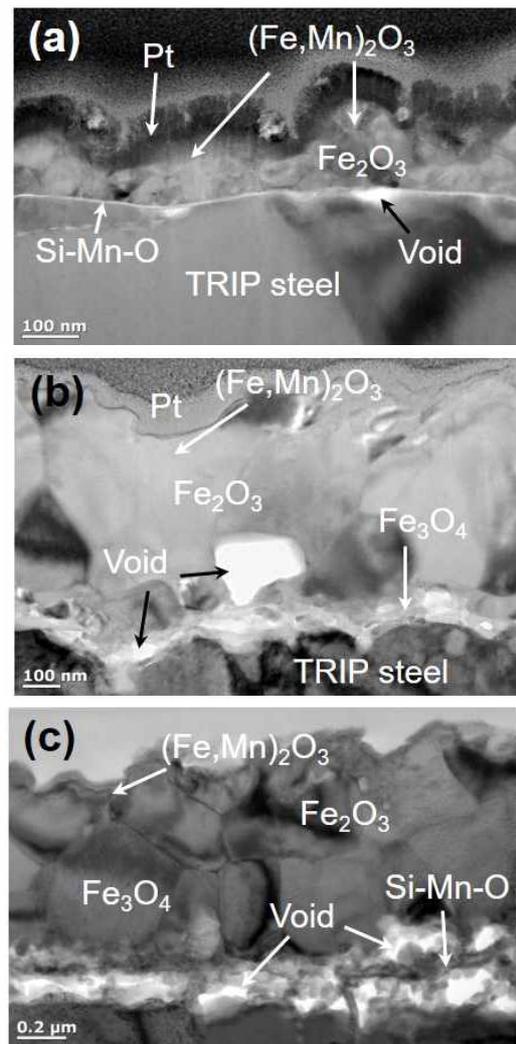


Fig. 7 Cross-sectional TEM micrographs showing the scales formed after extended oxidation at 700 °C for 60 s under different ambient conditions: (a)  $N_2 + 1\% O_2$ , (b)  $N_2 + 21\% O_2$ , and (c)  $100\% O_2$ . Note that the micrographs were taken at different magnifications.

TEM in conjunction with EDX, and is presented in Fig. 7. The scale thicknesses measured from the cross-sectional TEM micrographs are listed in Table 2, where they are compared with the thicknesses without the extended oxidation at 700 °C. As shown in Fig. 7a for the case of 1%  $O_2$ , no significant scale growth occurred during the extended oxidation. There was a thin amorphous oxide layer, which was rich in Si, underneath the Fe oxide scale. The EDX analysis revealed that the top region of the scale contained a significant amount of Mn, as much as 20 at%, in accordance with the GDOES result. Since no MnO peaks were detected from the GIXRD analyses, the Mn enriched on the top of the scale is likely to be in the

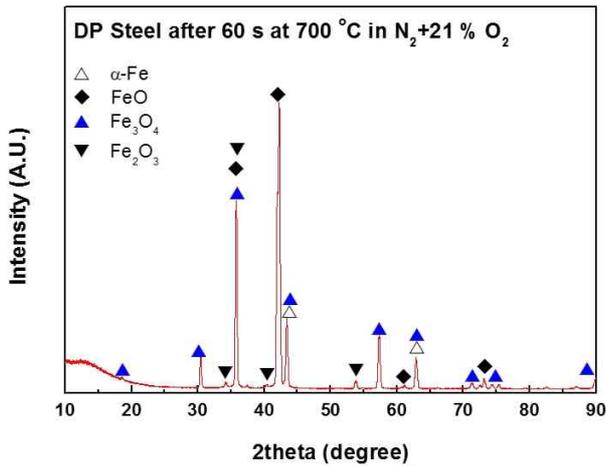


Fig. 8 GIXRD patterns for a dual phase steel sheet oxidized at 700 °C for 60 s under N<sub>2</sub> + 21% O<sub>2</sub> ambience by following the same thermal cycle as the TRIP steel samples. The dual phase steel was low in Si, with a composition of 0.02 wt% Si and 0.25 wt% Mn.

form of (Fe,Mn)<sub>2</sub>O<sub>3</sub>. As can be seen in Fig. 7b and c, the scale significantly grew when extended oxidation was performed in 21% and 100% O<sub>2</sub> atmospheres. In accordance with the GDOES results, the Mn content on top of the scale decreases with increasing P<sub>O<sub>2</sub></sub>, as listed in Table 3. Moreover, a greater number of voids formed in the amorphous layer of a Si-rich oxide underneath the scale with increasing P<sub>O<sub>2</sub></sub>.

#### 4. Discussion

Regardless of P<sub>O<sub>2</sub></sub> (0.01, 0.21, and 1 atm) in the oxidizing atmosphere, the TRIP steel exhibited scales with a multi-layered structure of (Fe,Mn)<sub>2</sub>O<sub>3</sub>/Fe<sub>2</sub>O<sub>3</sub>/Fe<sub>3</sub>O<sub>4</sub>/Si-Mn-O/steel upon heating to 700 °C or after isothermally holding at 700 °C for 60 s. The Fe<sub>3</sub>O<sub>4</sub> layer was very thin in all the cases except when oxidized at 700 °C for 60 s in a 100% O<sub>2</sub> atmosphere. As the Fe-oxide scale grew faster with increasing P<sub>O<sub>2</sub></sub>, there was a higher amount of void formation in the amorphous Si-rich Si-Mn-O oxide layer. These results indicate that the scale growth occurred predominantly by the outward diffusion of Fe, and the voids formed in the amorphous Si-rich oxide layer were the Kirkendall voids, formed because of the asymmetric diffusion of Fe and O across the scale layer.

It is well known that a multilayered scale composed of Fe<sub>2</sub>O<sub>3</sub>/Fe<sub>3</sub>O<sub>4</sub>/FeO/Fe is formed when a sheet of pure Fe was oxidized at temperatures above 570 °C under a P<sub>O<sub>2</sub></sub> high enough for Fe<sub>2</sub>O<sub>3</sub> to be formed at the outermost surface. Moreover, the fastest and slowest growing phases are known to be FeO and Fe<sub>2</sub>O<sub>3</sub>, respectively [15]. In the

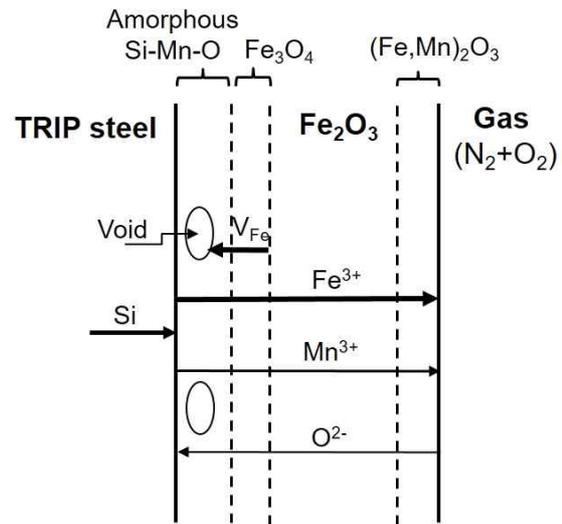


Fig. 9 Schematic illustration of the elemental transports involved in the scale growth and void formation in the present study.

Table 3 EDX results from the top surface regions of the scales shown in Fig. 7

| O <sub>2</sub> content (vol.%) | Composition (at.%) |       |       |
|--------------------------------|--------------------|-------|-------|
|                                | Fe                 | Mn    | O     |
| 1                              | 23.90              | 20.33 | 55.77 |
| 21                             | 30.13              | 8.90  | 60.98 |
| 100                            | 34.74              | 4.41  | 60.84 |

present study, however, the fastest growing oxide phase was Fe<sub>2</sub>O<sub>3</sub>, and the FeO phase was absent in the scale. This suggests that the scale growth on the TRIP steel surface should be influenced by the formation of the amorphous Si-rich oxide layer underneath the Fe oxide scale. It has been reported that the transport rate of Fe ions through an amorphous Si oxide depends on the charge state of the Fe ions, i.e., Fe<sup>3+</sup> diffusing much faster than Fe<sup>2+</sup> [20,21]. Accordingly, the faster transport of Fe<sup>3+</sup> across the amorphous layer resulted in the preferential growth of Fe<sub>2</sub>O<sub>3</sub> composed of Fe<sup>3+</sup> and O<sup>2-</sup>, while the formation of FeO, composed of Fe<sup>2+</sup> and O<sup>2-</sup>, was suppressed.

To further confirm the influence of the amorphous Si-rich oxide layer on the scale growth, a dual phase steel sheet containing 0.25 wt% Mn and 0.02 wt% Si, from which the formation of an amorphous Si-oxide layer could be neglected, was oxidized under N<sub>2</sub> + 21% O<sub>2</sub> atmosphere by following the same thermal cycle (heating and holding at 700 °C for 60 s) as the TRIP steel and then GIXRD analysis was performed for the oxide phases in the scale. As shown in Fig. 8, the GIXRD pattern ex-

hibited strong peaks of FeO and Fe<sub>3</sub>O<sub>4</sub> together with minor peaks of Fe<sub>2</sub>O<sub>3</sub>.

The elemental transport for the scale growth and void formation in this study are schematically depicted in Fig. 9. Void formation in the amorphous Si-rich oxide layer is likely due to the presence of an Fe<sub>3</sub>O<sub>4</sub> layer in between the Fe<sub>2</sub>O<sub>3</sub> and amorphous layers. It is known that Fe<sup>3+</sup> and cationic impurities in Fe<sub>2</sub>O<sub>3</sub> diffuse by an interstitial-type or interstitialcy mechanism [22]. Therefore, the outward diffusion of Fe and Mn through the Fe<sub>2</sub>O<sub>3</sub> layer would not involve an inward flow of vacancies. However, Fe ions (Fe<sup>2+</sup> and Fe<sup>3+</sup>) are known to diffuse by a vacancy mechanism in Fe<sub>3</sub>O<sub>4</sub> [15,23]. Therefore, Fe vacancies ( $V_{Fe}$ ) are likely formed at the Fe<sub>3</sub>O<sub>4</sub>/Fe<sub>2</sub>O<sub>3</sub> interface and diffuse inward into the amorphous Si-rich layer, where they agglomerate to form voids.

In general, oxidation of a metal leading to scale growth follows linear kinetics of scale growth in the initial stage of oxidation. After a certain period of linear growth, the oxidation follows a parabolic kinetics controlled by elemental diffusion. According to the Wagner's theory, the parabolic rate constant of an n-type oxide is independent of  $P_{O_2}$  in the ambient gas when the n-type oxide grows by diffusion of cationic components [24]. However, as summarized in Table 2, the oxide scale growth in this study was greatly enhanced by increasing  $P_{O_2}$  although the dominantly growing oxide was the n-type Fe<sub>2</sub>O<sub>3</sub>. This implies that the rate-limiting step in the oxidation of the TRIP steel for 60 s at 700 °C was the reaction at the scale/gas interface and that the outward diffusion rate of Fe through the scale was sufficiently fast. The increased reaction rate to form Fe<sub>2</sub>O<sub>3</sub> at the gas interface with increasing  $P_{O_2}$  was responsible not only for the enhanced scale growth but also for the relatively lower segregation of Mn at the scale surface and the increased void formation in the amorphous Si-Mn-O layer.

In the oxidation-reduction process for hot-dip galvanizing of TRIP steels, the amorphous Si-Mn-O layer underneath the Fe oxide scale cannot be reduced in the subsequent intercritical annealing stage and remains after hot-dip galvanizing. Therefore, the presence of voids in the amorphous Si-Mn-O layer would greatly increase the susceptibility of the Zn coating overlay being detached from the steel substrate. The present results suggest that the peroxidation should be performed under a low  $P_{O_2}$  atmosphere to suppress the void formation underneath the Fe oxide scale.

## 5. Summary

Oxidation behavior of a TRIP steel containing 1.6 wt%

Mn and 1.5 wt% Si during the pre-oxidation stage in the oxidation-reduction scheme was examined to determine the effect of  $P_{O_2}$  in the oxidizing atmosphere. Oxidation was performed by ramping up to 700 °C at a rate of 6 °C/s and then isothermal holding at 700 °C for 60 s under three different ambient gases at 1 atm: N<sub>2</sub> + 1% O<sub>2</sub>, N<sub>2</sub> + 21% O<sub>2</sub>, and 100% O<sub>2</sub>. Regardless of  $P_{O_2}$ , a multilayered scale composed of (Fe,Mn)<sub>2</sub>O<sub>3</sub>/Fe<sub>2</sub>O<sub>3</sub>/Fe<sub>3</sub>O<sub>4</sub>/Si-Mn-O/steel was formed upon heating to 700 °C. The multilayered scale structure was still maintained without the formation of FeO even after the extended oxidation at 700 °C for 60 s. The scale growth occurred predominantly by the growth of the outermost Fe<sub>2</sub>O<sub>3</sub> layer for all ambient conditions, and its growth rate significantly increased with increasing  $P_{O_2}$ , implying that the scale growth was reaction-controlled at the Fe<sub>2</sub>O<sub>3</sub>/gas interface. The enhanced growth rate of Fe oxide scale with increasing  $P_{O_2}$  resulted in the formation of more Kirkendall voids in the amorphous Si-Mn-O layer. In contrast to the alloying element Si, which was internally oxidized at the Fe-oxide scale/steel interface, the alloying element Mn had a great tendency to be externally oxidized at the scale surface forming (Fe,Mn)<sub>2</sub>O<sub>3</sub>, which increased with decreasing  $P_{O_2}$ . The predominant growth of Fe<sub>2</sub>O<sub>3</sub> and the absence of FeO in the scale formed on the TRIP steel surface were attributed to the presence of the amorphous Si-Mn-O layer through which Fe<sup>3+</sup> ions diffused much faster than Fe<sup>2+</sup> ions.

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